Applicant(s)/Patent Under Application/Control No. Reexamination 10/678,699 LIN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2824 Dang T. Nguyen **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 03-2004 US-2004/0042264 A1 Tran et al. 365/158 Α 05-2004 US-2004/0087038 A1 Costrini et al. 438/003 В US-С US-D US-Ε US-F US-G US-Н US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν O. Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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